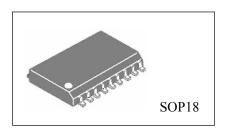
ULN2803F

Octal High Voltage, High Current Darlington Transistor Arrays

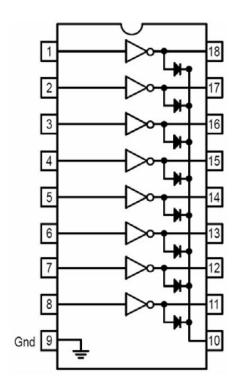
General Description

The eight NPN Darlington connected transistors in this family of arrays are ideally suited for interfacing between low logic level digital circuitry (such as TTL, CMOS or PMOS/NMOS) and the higher current/voltage requirements of lamps, relays, printer hammers or other similar loads for a broad range of computer, industrial, and consumer applications. All devices feature open–collector outputs and free wheeling clamp diodes for transient suppression.



The ULN2803F is designed to be compatible with standard TTL families while the ULN2804 is optimized for 6 to 15 volt high level CMOS or PMOS.

Pin Connection:



Absolute Maximum Ratings (T_A=25°C and rating apply to any one device in the package, unless otherwise noted.)

Characteristic	Symbol	Limit	Unit	
Output voltage	$V_{\rm O}$	50	V	
Input voltage	VI	30	V	
Collector current-continuous	Ic	500	mA/ch	
Base current-continuous	I_{B}	25	mA	
Clamp diode reverse voltage	VR	50	V	
Clamp diode forward current	I_{F}	500	mA	
Power Dissipation	P_{D}	0.92/1.31(Note)	W	
Operating temperature	Topr	-40 ∼ +85	$^{\circ}$	
Storage temperature	Tstg	- 55 ∼ +150	$^{\circ}$	
Junction temperature	TJ	125	$^{\circ}$	

Note: 1. On Glass Epoxy PCB (75 \times 114 \times 1.6 mm Cu 20%)

Electrical Characteristics (Ta=25°C, unless otherwise noted)

characteristic S	Symbol	Test condition	limit			Unit
	Symbol		Min.	Тур.	Max.	Omt
Output leakage current (Fig.1)	Ι	V_{O} =50V, T_{A} =70°C			100	μΑ
	I _{CEX}	$V_O=50V,T_A=25^{\circ}C$			50	
Collector-Emitter saturation voltage(Fig.2)	V _{CE(sat)}	Ic=350mA,I _B =500μA		1.1	1.6	V
		Ic=200mA,I _B =350μA		0.95	1.3	
		Ic=100mA,I _B =250μA		0.85	1.1	
Input current-on condition (Fig.4)	I _{I(on)}	V _I =3.85V		1.1	1.35	mA
Input voltage-on condition (Fig.5)		V _{CE} =2.0V,I _C =200mA		1.7	2.4	V
	V _{I(on)}	V _{CE} =2.0V,I _C =250mA		1.75	2.7	
		V _{CE} =2.0V,I _C =300mA		1.8	3.0	
Input current-off Condition (Fig.3)	I _{I(off)}	I _C =500μA, T _A =70°C	50	100		μΑ
Input capacitance	CI			15	25	pF
Turn-on delay time (50% E _I to 50% E _O)	ton			0.25	1.0	μs
Turn-off delay time (50% E _I to 50% E _O)	toff			0.25	1.0	μs
Clamp diode leakage	I_R	T _A =25°C			50	μА
Current(V _R =50V)(Fig.6)		T _A =70°C			100	
Clamp diode forward Voltage (Fig.7)	V _F	I _F =350mA		1.5	2.0	V

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^{2.} $R_{\theta JA} = 55^{\circ} C/W$

^{3.} Do not exceed maximum current limit per driver.

Test Circuit

Figure 1.

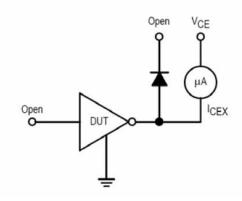


Figure 3.

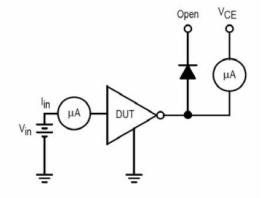


Figure 5.

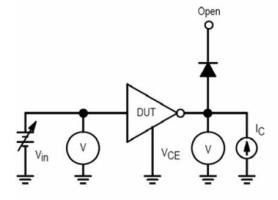


Figure 2.

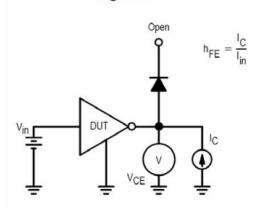


Figure 4.

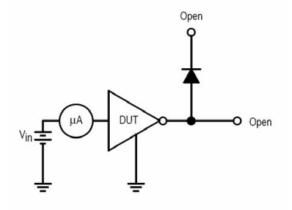
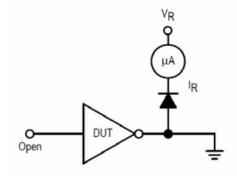
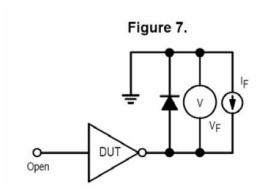
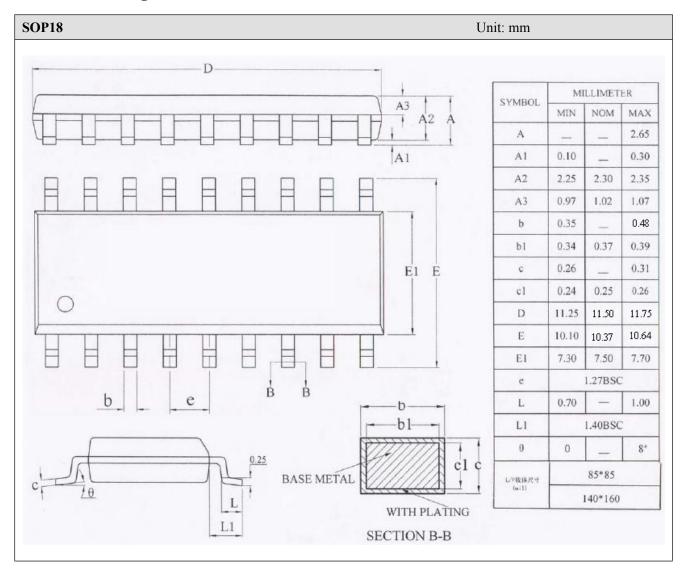


Figure 6.





Outline Drawing



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